Search Notes				

Application/Control		Applicant(s)/Patent under Reexamination	
10/700,311	TAKAHASHI	ET AL.	
Examiner	Art Unit		
HELEN SHIBRU	2621		

SEARCHED					
Class	Subclass	Date	Examiner		
386	96,125,12 4,46,52	5/14/2007	нѕ		
	•	•			
	·		•		
	•				
			<u>,</u>		
<u> </u>					
1					
<u></u>					

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
·····		· <u></u>	1		

SEARCH NOT (INCLUDING SEARCH		)
	DATE	EXMR
modified Dear Con modified sear Con	।/१४/०३	W
modified search	02/15/08	60
	·	
	·	<del></del>